# Eye mask measurement accuracy

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#### **Problem statements:**

1. Eye mask margin measurements can be misleading and less than accurate

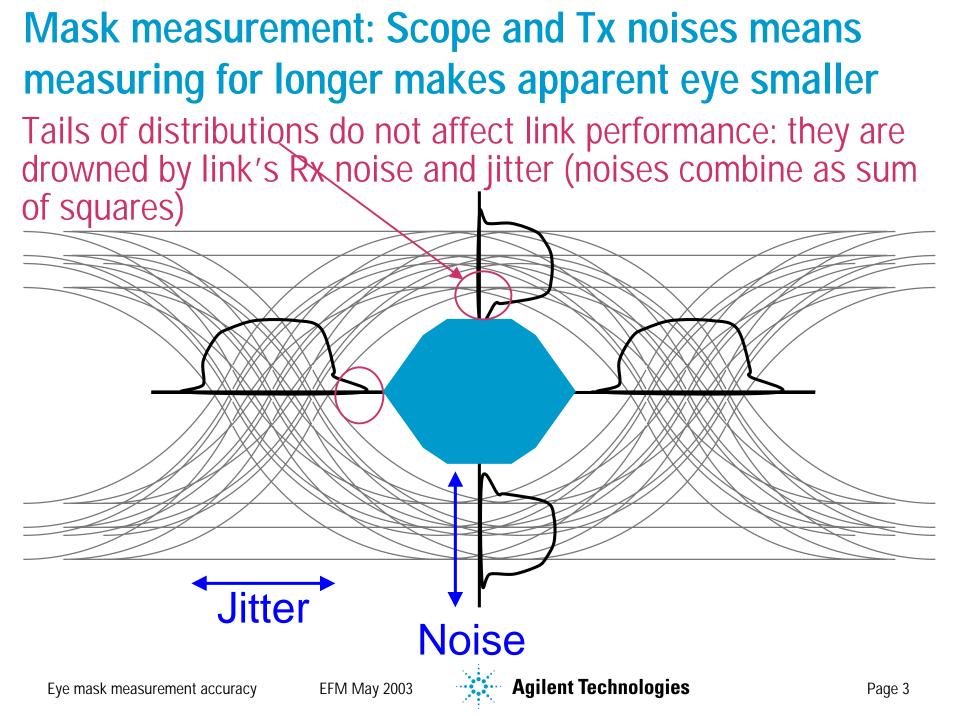
2. Eye measurement procedure is not fully specified in reference standards

3. Seeking correlation between TDP and other measurement methods

This is a general analysis, not specific to any bit rate

Eye mask addresses high probability impairments ("deterministic"); various noise effects can give misleading results





Noises combine as sum of squares: Typical example for 10G Ethernet measurement Probability distribution (Tx under test) combines with probability distribution (scope) to determine mask hit rate

(Measurement technique determines scatter in measurement)

Measurement:

 $(Tx noise)^2$  + (scope noise)<sup>2</sup> = (measurement total noise)<sup>2</sup> example:  $0.03^2$  +  $0.02^2$  =  $0.036^2$ 

Target use:

 $(Tx noise)^2 + (Rx noise)^2 = (system total noise)^2$ example:  $0.03^2 + 0.139^2 = 0.142^2$ 

Drowned by link Rx, not important at this level

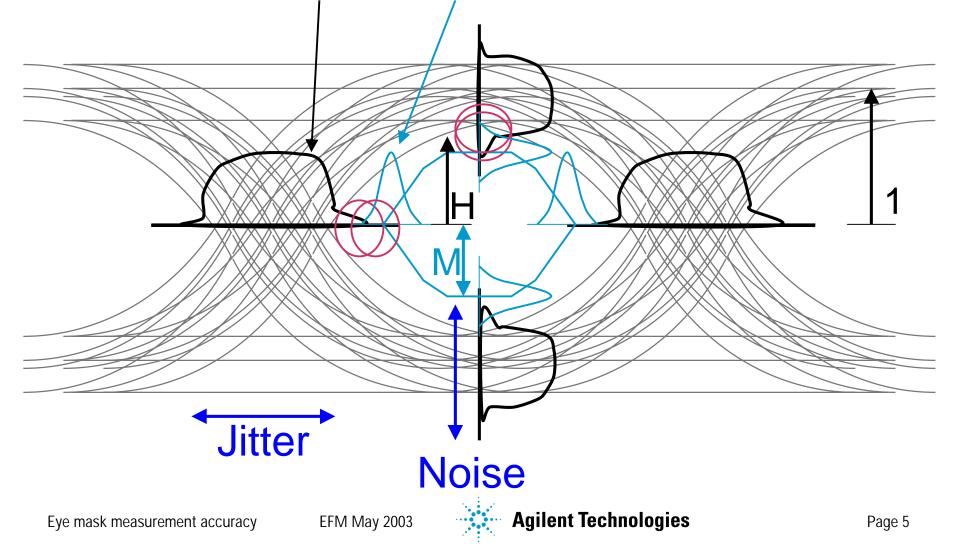
#### And see backup

Eye mask measurement accuracy



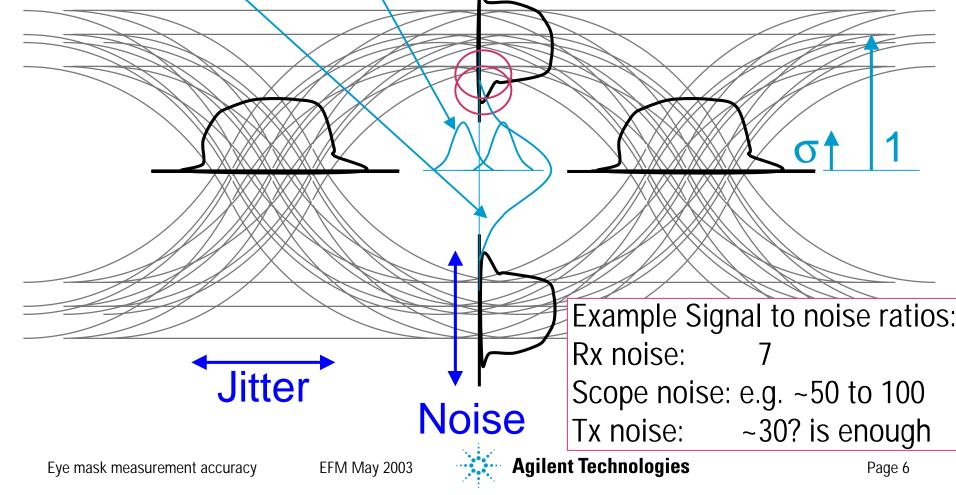
# Scope and Tx noises means measuring for longer makes apparent eye smaller:

Distributions of both DUT and instrument contribute to mask hits



#### Real receiver noise is much greater than scope or DUT noise In actual use, tails of Tx distributions are drowned by

link's Rx noise and jitter



#### **Number of samples**

Even modern sampling scopes miss most of the signal

e.g. 40 ksamples/s

as slide 5

Good for finding high probability effects and for diagnostic analysis

Actual system or TDP test takes 125,000 to 10,000,000 ksamples/s

as slide 6

Do not recommend using eye mask on scope (DCA) to characterise low probabilities: TDP spec addresses these

EFM May 2003



# Theoretical analysis of relation between actual transmitter penalty and observed mask margin: method

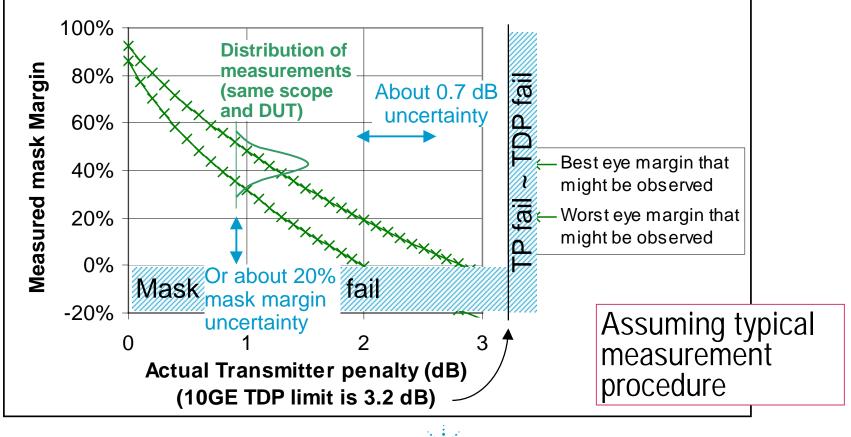
1. Calculate relation between transmitter penalty (TP) and mask margin (MM) assuming no noise anywhere:

TP =  $10*\log 10(1/H)$ , MM=(H-M)/(1-M) where H is height of inner eye and M is height of mask\*

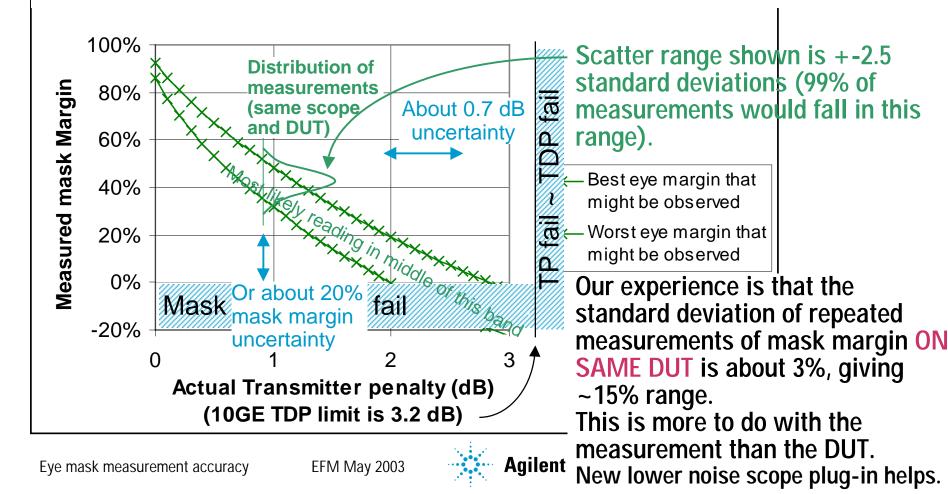
- 2. Extend calculation to allow for penalty of Tx noise
- 3. Extend calculation to include scope noise
- 4. Find position in tail of distribution representing 0 hits
- 5. Find likely scatter around that point
- 6. Graph out likely range of apparent mask margin vs. actual transmitter penalty for a family of transmitters from good to bad

\* See slide 5 Analysis assumes =0.5 Eye mask measurement accuracy EFM May 2003

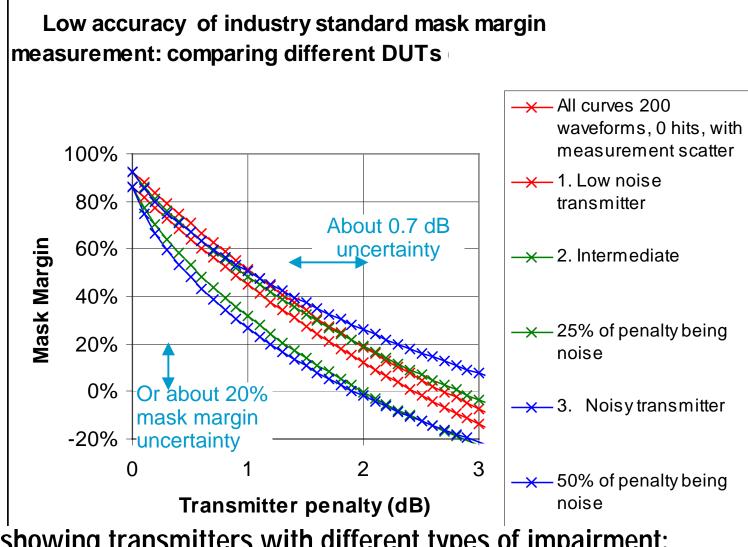
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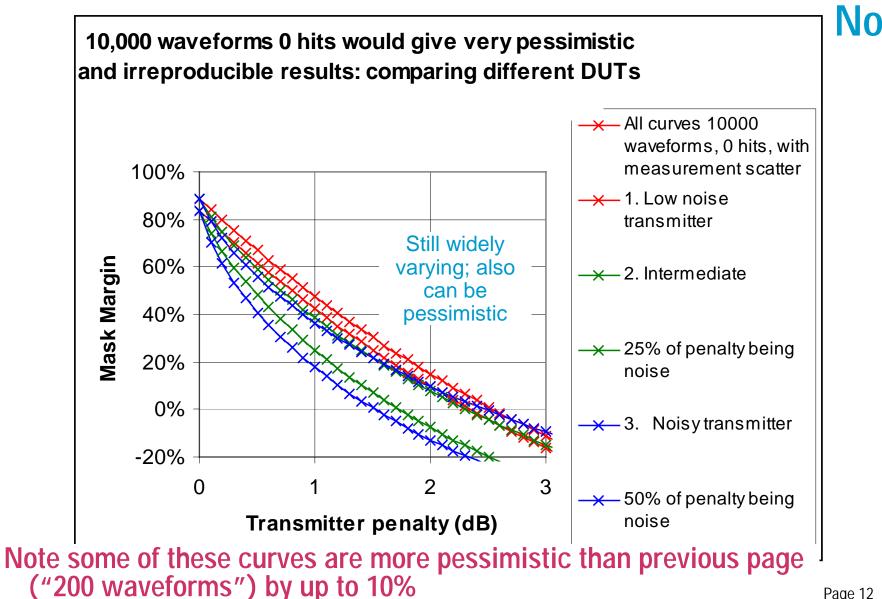


#### Industry standard: 200 waveforms, no hits

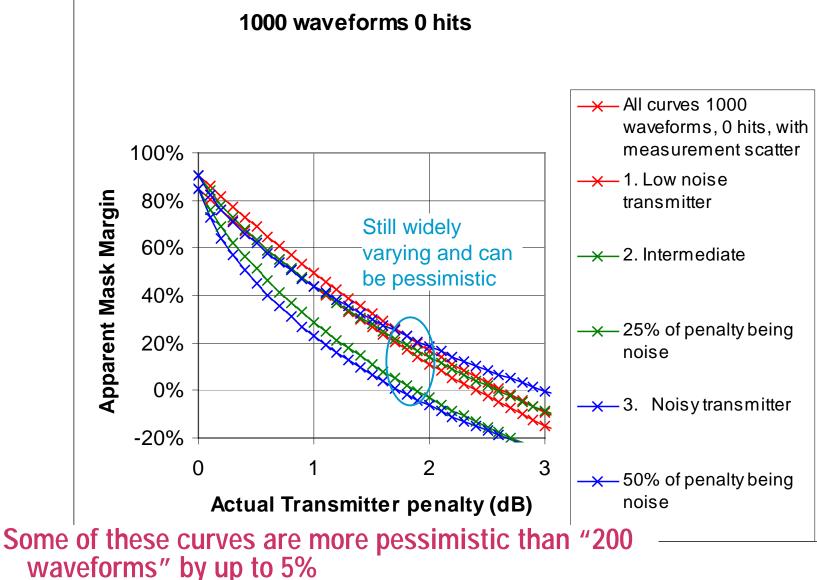


Now showing transmitters with different types of impairment: deterministic and random. 3 examples in 3 colours.

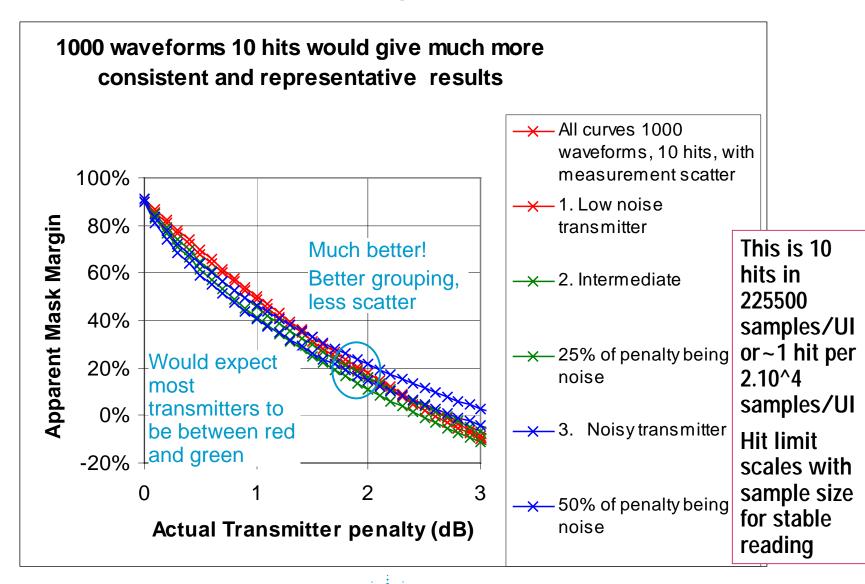
# Can we get better accuracy with more waveforms?



# Intermediate position still suffers from overmeasured noise and scattered results



#### **Proposal for best accuracy**



# Numbers of waveforms, number of hits

Need a reasonable number of DCA "waveforms" to get samples from all likely patterns

e.g. 10 sweeps would be too few

We believe "200 waveforms" is industry baseline, and different companies add margin to this in different ways

This number is widely assumed but we can't find it written down in any standard

Criterion of 0 hits gives poor reproducibility, for any number of waveforms

Increasing the number of samples with 0 hits overmeasures random effects and may be affected by scope noise

#### And see backup

Eye mask measurement accuracy



# Summary

#### Mask margin based on very few or zero hits can be misleading and generate unrepeatable results

Increasing the number of waveforms reduces the apparent mask margin, does not make the measurement much more repeatable and overmeasures transmitter and scope noise

Increasing the number of waveforms AND allowing a finite number of hits improves both measurement repeatability and relevance

#### Need to define a set proportion of hits/sample/UI

Too low a proportion: large measurement errors and unrepresentative (too pessimistic)

Too high a proportion: too lenient in some cases

1 in 2.10<sup>4</sup> hits/sample/UI: about right

10 sided masks in Ethernet standards should be adequate; no need to add more margin except for ageing

TDP test is the "gold standard", not the mask

TDP measurement is designed to be representative of actual performance

#### Backup Sonet

Mask margin measurements with 4 sided masks (OC-48, OC-192) are expected to be less reproducible unless care is taken, because the convolution of a slanting trajectory of the waveform against the rectangular mask gives a "fat tailed distribution"

**Relation of waveforms to samples** 

I have assumed 451 samples across scope screen and 2 UI/screen (20 ps/div). I believe that older scopes contemporary with OFSTP-4 would have been in this ballpark

"Number of waveforms" means number of samples x samples/screen

Thus "200 waveforms" gives 90200 samples in all, of which 45100 are in the eye compared with the mask

Modern scopes have controllable samples/screen up to 4096

Of the samples in the right UI (where the mask is), only 1/4 relate to 010 and 101 patterns which determine the penalty

Of these, only a fraction come anywhere near the mask (mask is 0.5 UI long anyway)

Signal and noise levels

signal to noise ratio = Q = (1/2 eye height)/(RMS noise)